

## 12-BIT, ULTRALOW GLITCH, VOLTAGE OUTPUT DIGITAL-TO-ANALOG CONVERTER

### FEATURES

- 2.7-V to 5.5-V Single Supply
- 12-Bit Linearity and Monotonicity
- Rail-to-Rail Voltage Output
- Settling Time: 5  $\mu$ s (Max)
- Ultralow Glitch Energy: 0.1 nVs
- Low Power: 200  $\mu$ A (Max)
- Power Down: 2  $\mu$ A (Max)
- Power-On Reset to Zero Scale
- SPI-Compatible Serial Interface: Up to 50 MHz
- Daisy-Chain Capability
- Asynchronous Hardware Clear
- Specified Temperature Range:  $-40^{\circ}\text{C}$  to  $105^{\circ}\text{C}$
- Small, 2-mm x 3-mm, 12-Lead SON Package

### APPLICATIONS

- Portable Battery-Powered Instruments
- Digital Gain and Offset Adjustment
- Programmable Voltage and Current Sources
- Programmable Attenuators
- Industrial Process Control

### DESCRIPTION

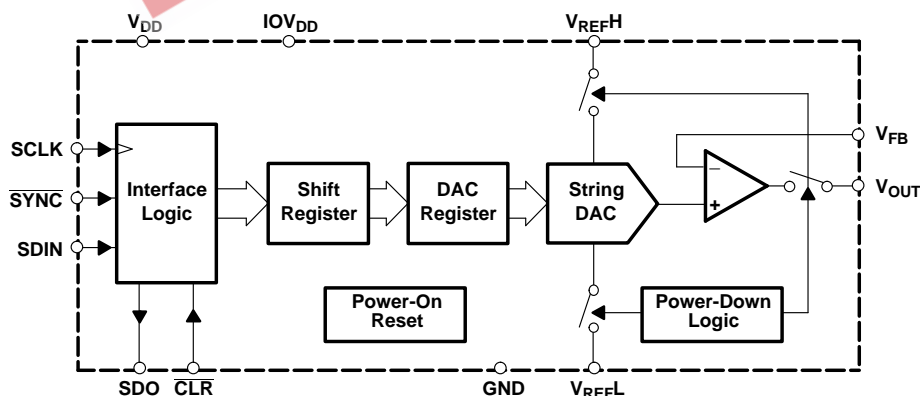
The DAC7551 is a single-channel, voltage-output DAC with exceptional linearity and monotonicity. Its proprietary architecture minimizes glitch energy. The low-power DAC7551 operates from a single 2.7-V to 5.5-V supply. The DAC7551 output amplifiers can drive a 2-k $\Omega$ , 200-pF load rail-to-rail with 5- $\mu$ s settling time; the output range is set using an external voltage reference.

The 3-wire serial interface operates at clock rates up to 50 MHz and is compatible with SPI, QSPI, Microwire™, and DSP interface standards. The parts incorporate a power-on-reset circuit to ensure that the DAC outputs power up to zero volts and remain there until a valid write cycle to the device takes place. The parts contain a power-down feature that reduces the current consumption of the device to under 2  $\mu$ A.

The small size and low-power operation makes the DAC7551 ideally suited for battery-operated portable applications. The power consumption is typically 0.5 mW at 5 V, 0.23 mW at 3 V, and reduces to 1  $\mu$ W in power-down mode.

The DAC7551 is available in a 12-lead SON package and is specified over  $-40^{\circ}\text{C}$  to  $105^{\circ}\text{C}$ .

### FUNCTIONAL BLOCK DIAGRAM



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

Microwire is a trademark of National Semiconductor Corp..



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

#### ORDERING INFORMATION<sup>(1)</sup>

PRODUCT	PACKAGE	PACKAGE DESIGNATOR	SPECIFIED TEMPERATURE RANGE	PACKAGE MARKING	ORDERING NUMBER	TRANSPORT MEDIA
DAC7551	12 SON	DRN	–40°C TO 105°C	D51	DAC7551IDRNT	250-piece Tape and Reel
					DAC7551IDRNR	2500-piece Tape and Reel

(1) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI Web site at [www.ti.com](http://www.ti.com).

#### ABSOLUTE MAXIMUM RATINGS

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

	UNIT
$V_{DD}$ to GND	–0.3 V to 6 V
Digital input voltage to GND	–0.3 V to $V_{DD} + 0.3$ V
$V_{OUT}$ to GND	–0.3 V to $V_{DD} + 0.3$ V
Operating temperature range	–40°C to 105°C
Storage temperature range	–65°C to 150°C
Junction temperature ( $T_J$ Max)	150°C

(1) Stresses above those listed under “Absolute Maximum Ratings” may cause permanent damage to the device. Exposure to absolute maximum conditions for extended periods may affect device reliability.

**ELECTRICAL CHARACTERISTICS**

$V_{DD} = 2.7\text{ V to }5.5\text{ V}$ ,  $V_{REFH} = V_{DD}$ ,  $V_{REFL} = \text{GND}$ ,  $R_L = 2\text{ k}\Omega$  to GND;  $C_L = 200\text{ pF}$  to GND; all specifications  $-40^\circ\text{C}$  to  $105^\circ\text{C}$ , unless otherwise specified

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS
<b>STATIC PERFORMANCE<sup>(1)</sup></b>					
Resolution			12		Bits
Relative accuracy			$\pm 0.35$	$\pm 1$	LSB
Differential nonlinearity	Specified monotonic by design		$\pm 0.08$	$\pm 0.5$	LSB
Offset error				$\pm 12$	mV
Zero-scale error	All zeroes loaded to DAC register			$\pm 12$	mV
Gain error				$\pm 0.15$	%FSR
Full-scale error				$\pm 0.5$	%FSR
Zero-scale error drift			7		$\mu\text{V}/^\circ\text{C}$
Gain temperature coefficient			3		ppm of FSR/ $^\circ\text{C}$
PSRR	$V_{DD} = 5\text{ V}$		0.75		mV/V
<b>OUTPUT CHARACTERISTICS<sup>(2)</sup></b>					
Output voltage range		$2 \times V_{REFL}$		$V_{REFH}$	V
Output voltage settling time	$R_L = 2\text{ k}\Omega$ ; $0\text{ pF} < C_L < 200\text{ pF}$			5	$\mu\text{s}$
Slew rate			1		V/ $\mu\text{s}$
Capacitive load stability	$R_L = \infty$		470		pF
	$R_L = 2\text{ k}\Omega$		1000		
Digital-to-analog glitch impulse	1 LSB change around major carry		0.1		nV-s
Digital feedthrough			0.1		nV-s
Output noise density (10-kHz offset frequency)			70		nV/ $\text{rtHz}$
Total harmonic distortion	$F_{OUT} = 1\text{ kHz}$ , $F_S = 1\text{ MSPS}$ , $\text{BW} = 20\text{ kHz}$		-85		dB
DC output impedance			1		$\Omega$
Short-circuit current	$V_{DD} = 5\text{ V}$		50		mA
	$V_{DD} = 3\text{ V}$		20		
Power-up time	Coming out of power-down mode, $V_{DD} = 5\text{ V}$		15		$\mu\text{s}$
	Coming out of power-down mode, $V_{DD} = 3\text{ V}$		15		
<b>REFERENCE INPUT</b>					
$V_{REFH}$ , Input range		0		$V_{DD}$	V
$V_{REFL}$ , Input range	$V_{REFL} < V_{REFH}$	0	GND	$V_{DD}$	V
Reference input impedance			100		k $\Omega$
Reference current	$V_{REF} = V_{DD} = 5\text{ V}$		130	250	$\mu\text{A}$
	$V_{REF} = V_{DD} = 3\text{ V}$		65	123	
<b>LOGIC INPUTS<sup>(2)</sup></b>					
Input current				$\pm 1$	$\mu\text{A}$
$V_{IN\_L}$ , Input low voltage	$V_{DD} = 5\text{ V}$			$0.3 V_{DD}$	V
$V_{IN\_H}$ , Input high voltage	$V_{DD} = 3\text{ V}$	$0.7 V_{DD}$			V
Pin capacitance				3	pF

(1) Linearity tested using a reduced code range of 30 to 4065; output unloaded.

(2) Specified by design and characterization, not production tested.

**ELECTRICAL CHARACTERISTICS (Continued)**

$V_{DD} = 2.7\text{ V to }5.5\text{ V}$ ,  $V_{REFH} = V_{DD}$ ,  $V_{REFL} = \text{GND}$ ,  $R_L = 2\text{ k}\Omega$  to GND;  $C_L = 200\text{ pF}$  to GND; all specifications  $-40^\circ\text{C to }105^\circ\text{C}$ , unless otherwise specified

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
<b>POWER REQUIREMENTS</b>					
$V_{DD}$		2.7		5.5	V
$I_{DD}$ (normal operation)	DAC active and excluding load current $V_{IH} = V_{DD}$ and $V_{IL} = \text{GND}$				
$V_{DD} = 3.6\text{ V to }5.5\text{ V}$			150	200	$\mu\text{A}$
$V_{DD} = 2.7\text{ V to }3.6\text{ V}$			100	150	
$I_{DD}$ (all power-down modes)	$V_{IH} = V_{DD}$ and $V_{IL} = \text{GND}$				
$V_{DD} = 3.6\text{ V to }5.5\text{ V}$			0.2	2	$\mu\text{A}$
$V_{DD} = 2.7\text{ V to }3.6\text{ V}$			0.05	2	
Reference input impedance			100		$\text{k}\Omega$
<b>POWER EFFICIENCY</b>					
$I_{OUT}/I_{DD}$	$I_{LOAD} = 2\text{ mA}$ , $V_{DD} = 5\text{ V}$		93%		

EEPW 电子产品世界  
.com.cn

### TIMING CHARACTERISTICS<sup>(1)(2)</sup>

$V_{DD} = 2.7\text{ V to }5.5\text{ V}$ ,  $R_L = 2\text{ k}\Omega\text{ to GND}$ ; all specifications  $-40^\circ\text{C to }105^\circ\text{C}$ , unless otherwise specified

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS
$t_1^{(3)}$ SCLK cycle time	$V_{DD} = 2.7\text{ V to }3.6\text{ V}$	20			ns
	$V_{DD} = 3.6\text{ V to }5.5\text{ V}$	20			
$t_2$ SCLK HIGH time	$V_{DD} = 2.7\text{ V to }3.6\text{ V}$	10			ns
	$V_{DD} = 3.6\text{ V to }5.5\text{ V}$	10			
$t_3$ SCLK LOW time	$V_{DD} = 2.7\text{ V to }3.6\text{ V}$	10			ns
	$V_{DD} = 3.6\text{ V to }5.5\text{ V}$	10			
$t_4$ $\overline{\text{SYNC}}$ falling edge to SCLK falling edge setup time	$V_{DD} = 2.7\text{ V to }3.6\text{ V}$	4			ns
	$V_{DD} = 3.6\text{ V to }5.5\text{ V}$	4			
$t_5$ Data setup time	$V_{DD} = 2.7\text{ V to }3.6\text{ V}$	5			ns
	$V_{DD} = 3.6\text{ V to }5.5\text{ V}$	5			
$t_6$ Data hold time	$V_{DD} = 2.7\text{ V to }3.6\text{ V}$	4.5			ns
	$V_{DD} = 3.6\text{ V to }5.5\text{ V}$	4.5			
$t_7$ SCLK falling edge to $\overline{\text{SYNC}}$ rising edge	$V_{DD} = 2.7\text{ V to }3.6\text{ V}$	0			ns
	$V_{DD} = 3.6\text{ V to }5.5\text{ V}$	0			
$t_8$ Minimum $\overline{\text{SYNC}}$ HIGH time	$V_{DD} = 2.7\text{ V to }3.6\text{ V}$	20			ns
	$V_{DD} = 3.6\text{ V to }5.5\text{ V}$	20			
$t_9$ SCLK falling edge to SDO valid	$V_{DD} = 2.7\text{ V to }3.6\text{ V}$	TBD			ns
	$V_{DD} = 3.6\text{ V to }5.5\text{ V}$	TBD			
$t_{10}$ $\overline{\text{CLR}}$ pulse width low	$V_{DD} = 2.7\text{ V to }3.6\text{ V}$	TBD			ns
	$V_{DD} = 3.6\text{ V to }5.5\text{ V}$	TBD			

- (1) All input signals are specified with  $t_R = t_F = 1\text{ ns}$  (10% to 90% of  $V_{DD}$ ) and timed from a voltage level of  $(V_{IL} + V_{IH})/2$ .
- (2) See Serial Write Operation timing diagram [Figure 1](#).
- (3) Maximum SCLK frequency is 50 MHz at  $V_{DD} = 2.7\text{ V to }5.5\text{ V}$ .

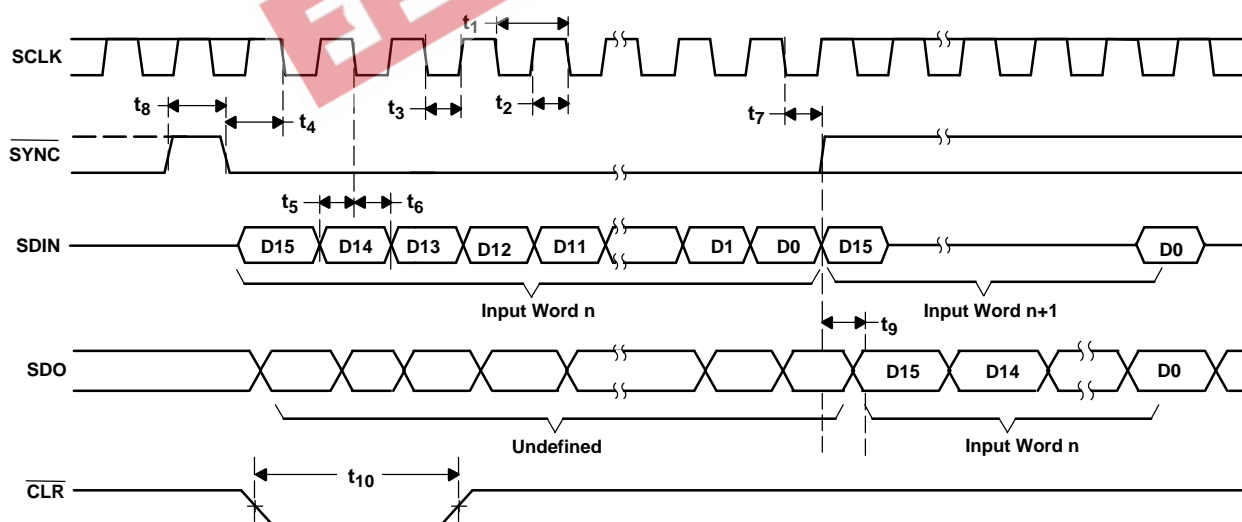
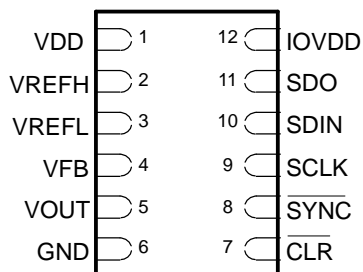


Figure 1. Serial Write Operation

**PIN DESCRIPTION**

**DRN PACKAGE  
(TOP VIEW)**



**Terminal Functions**

TERMINAL		DESCRIPTION
NO.	NAME	
1	VDD	Analog voltage supply input
2	VREFH	Positive reference voltage input
3	VREFL	Negative reference voltage input
4	VFB	DAC amplifier sense input.
5	VOUT	Analog output voltage from DAC
6	GND	Ground
7	CLR	Asynchronous input to clear the DAC registers. When CLR is low, the DAC register is set to 000H and the output voltage to 0 V.
8	SYNC	Frame synchronization input. The falling edge of the SYNC pulse indicates the start of a serial data frame shifted out to the DAC7551.
9	SCLK	Serial clock input
10	SDIN	Serial data input
11	SDO	Serial data output
12	IOVDD	I/O voltage supply input

PRODUCT PREVIEW

**TYPICAL CHARACTERISTICS**

**LINEARITY ERROR AND DIFFERENTIAL LINEARITY ERROR VS DIGITAL INPUT CODE**

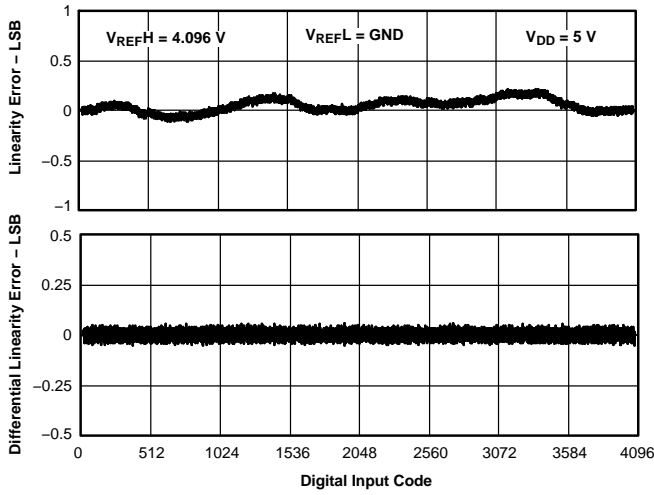


Figure 2.

**LINEARITY ERROR AND DIFFERENTIAL LINEARITY ERROR VS DIGITAL INPUT CODE**

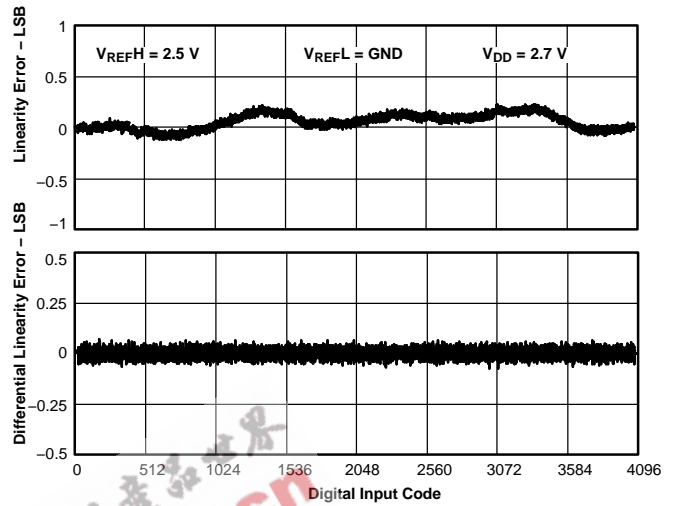


Figure 3.

**ZERO-SCALE ERROR VS FREE-AIR TEMPERATURE**

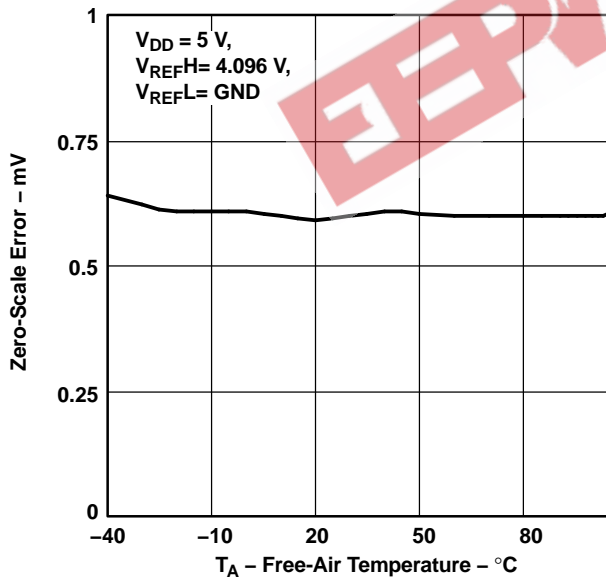


Figure 4.

**ZERO-SCALE ERROR VS FREE-AIR TEMPERATURE**

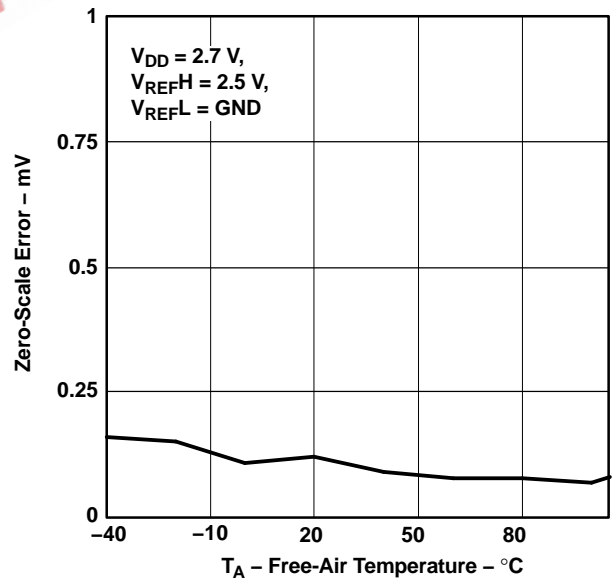


Figure 5.

PRODUCT PREVIEW

TYPICAL CHARACTERISTICS (continued)

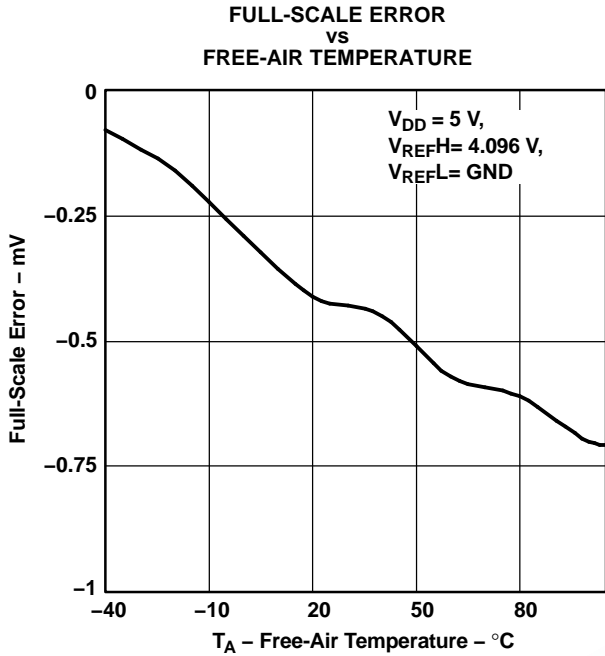


Figure 6.

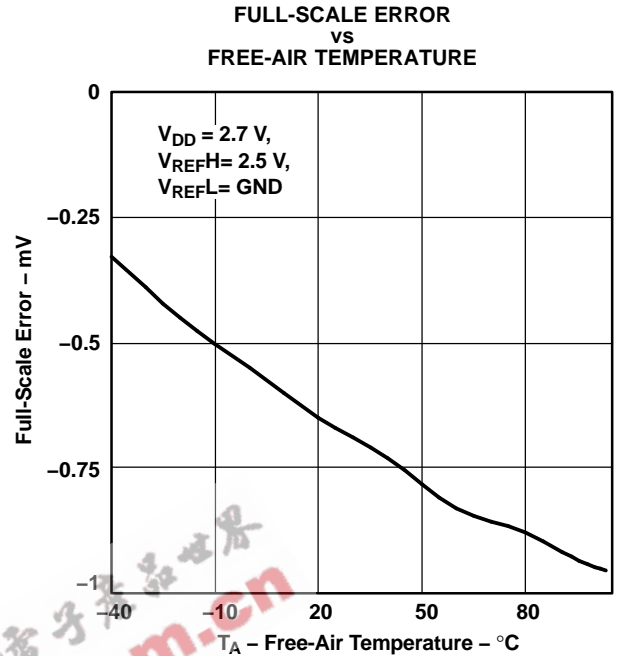


Figure 7.

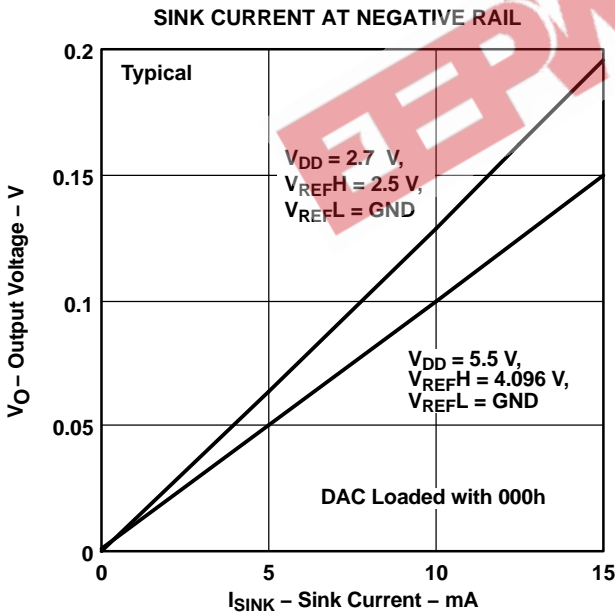


Figure 8.

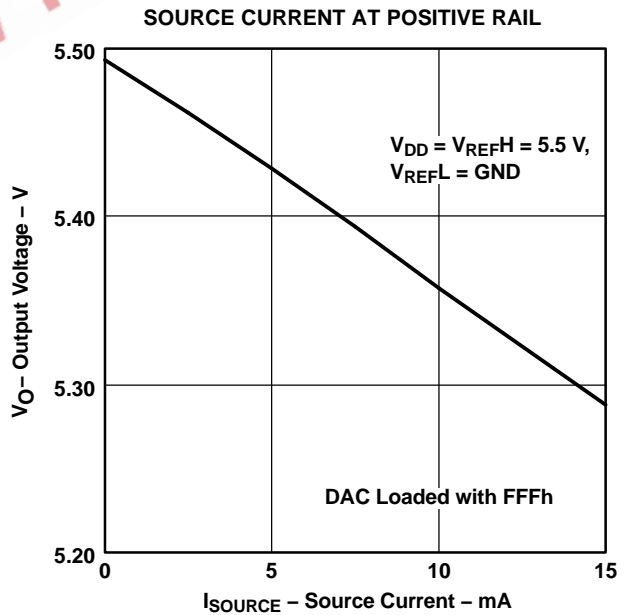


Figure 9.

PRODUCT PREVIEW



**TYPICAL CHARACTERISTICS (continued)**

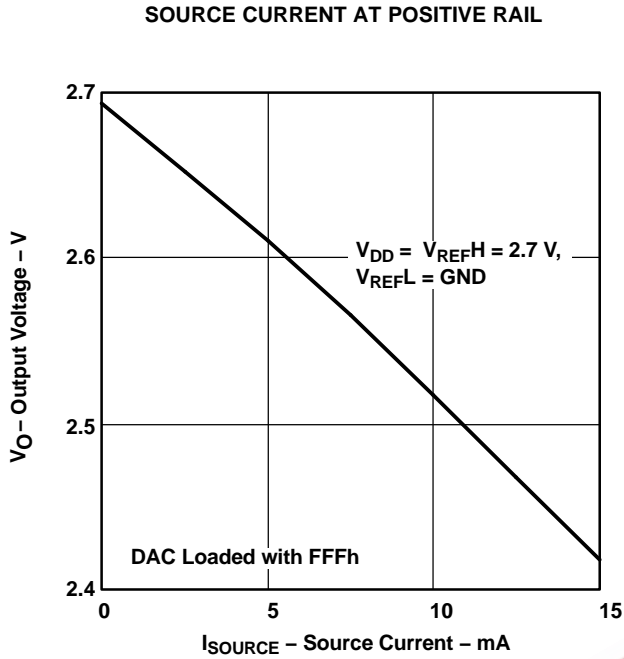


Figure 10.

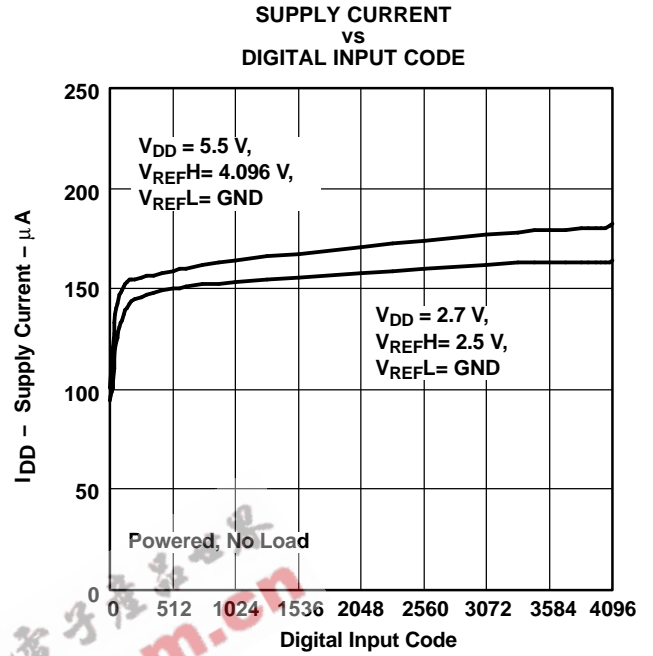


Figure 11.

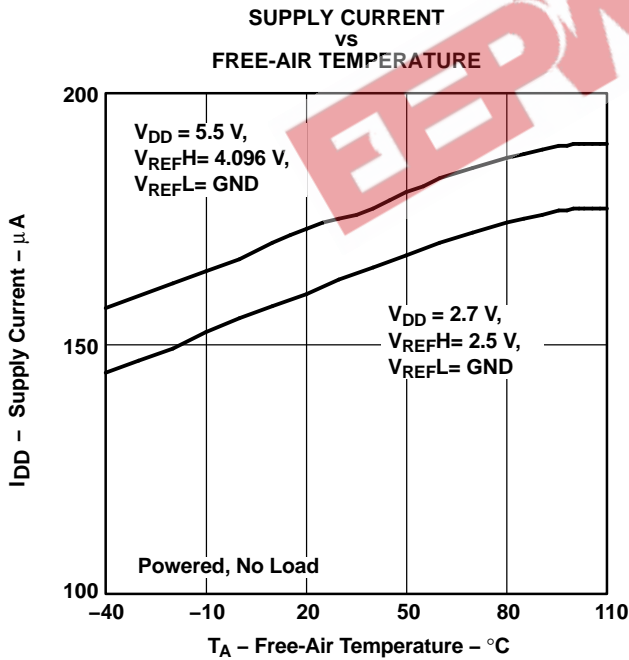


Figure 12.

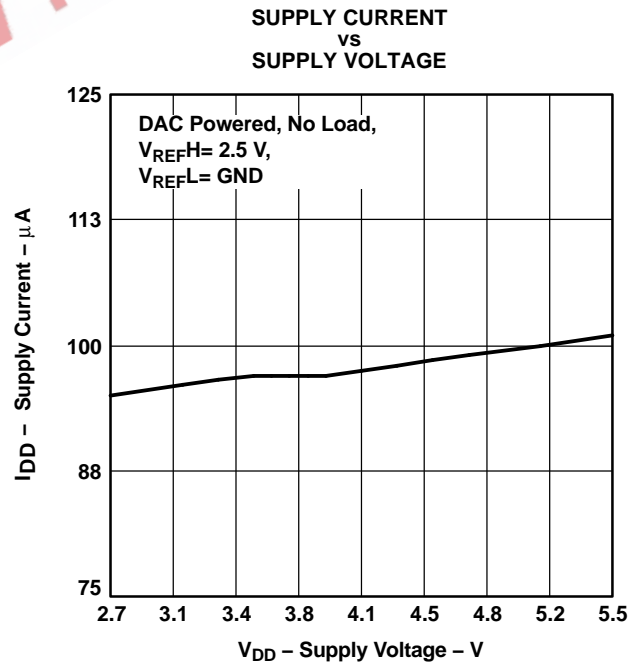
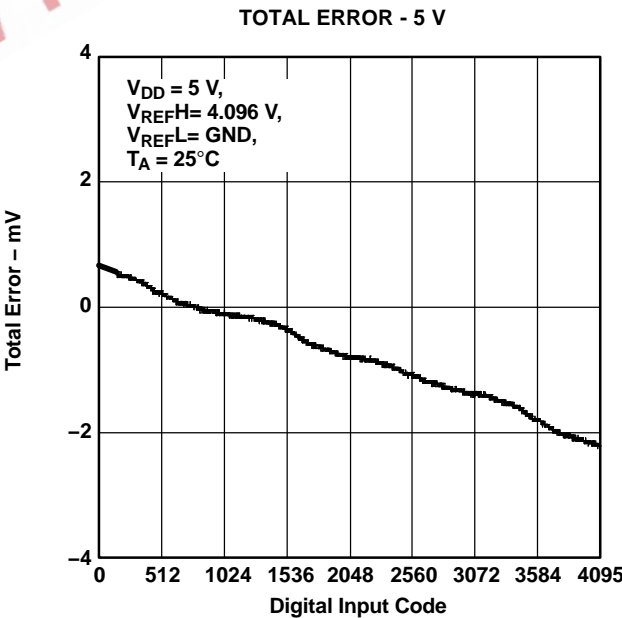
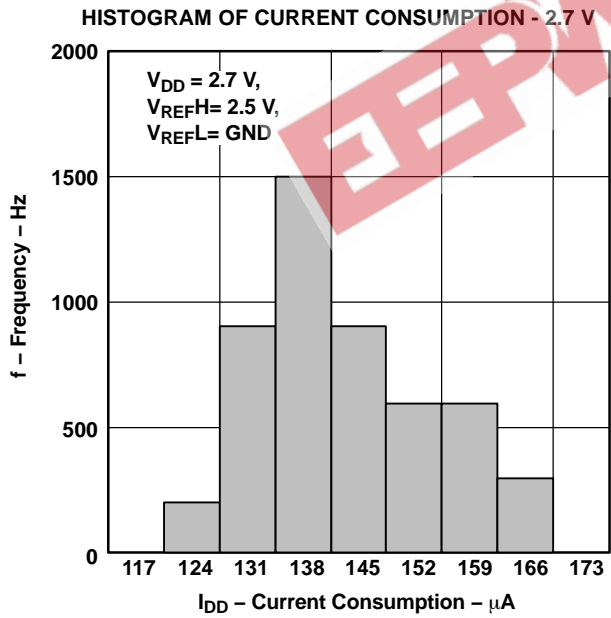
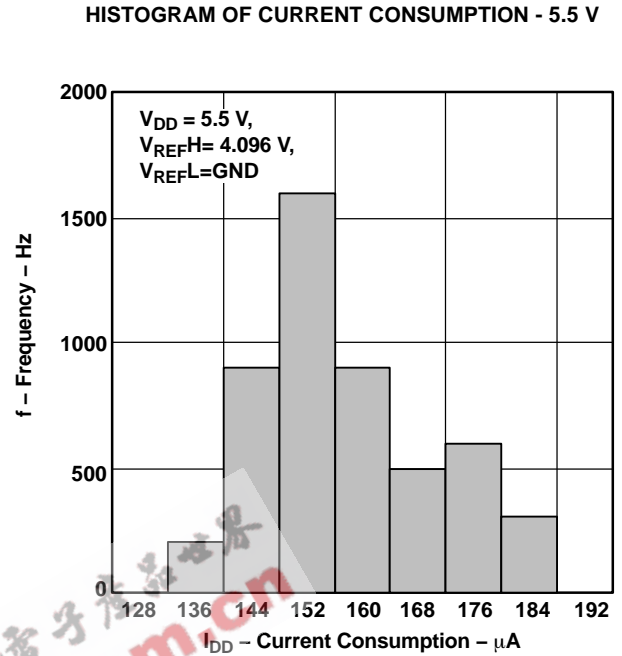
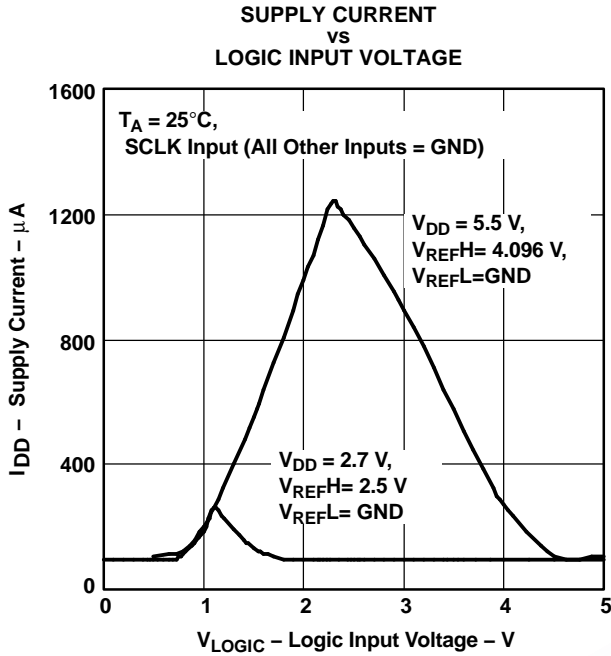


Figure 13.

TYPICAL CHARACTERISTICS (continued)



PRODUCT PREVIEW

TYPICAL CHARACTERISTICS (continued)

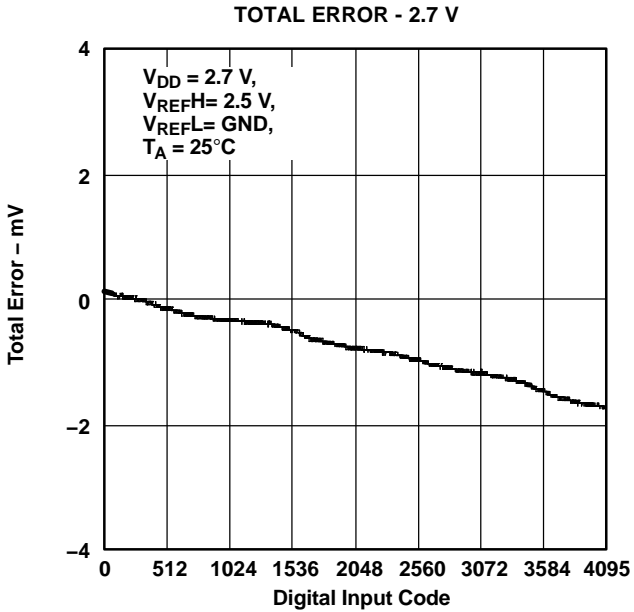


Figure 18.

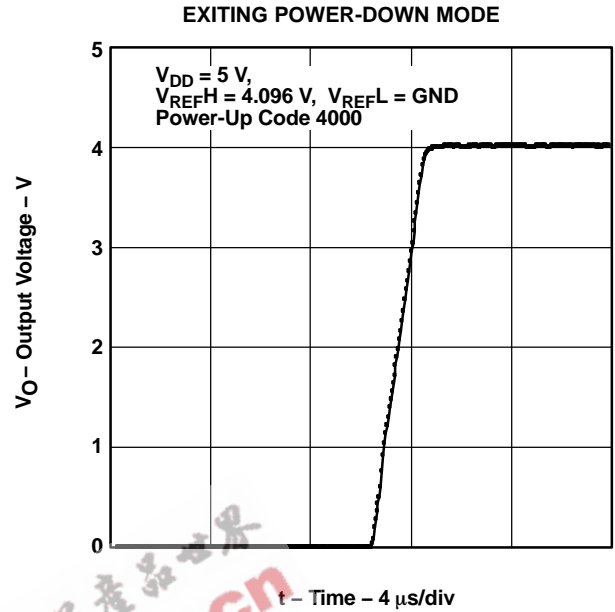
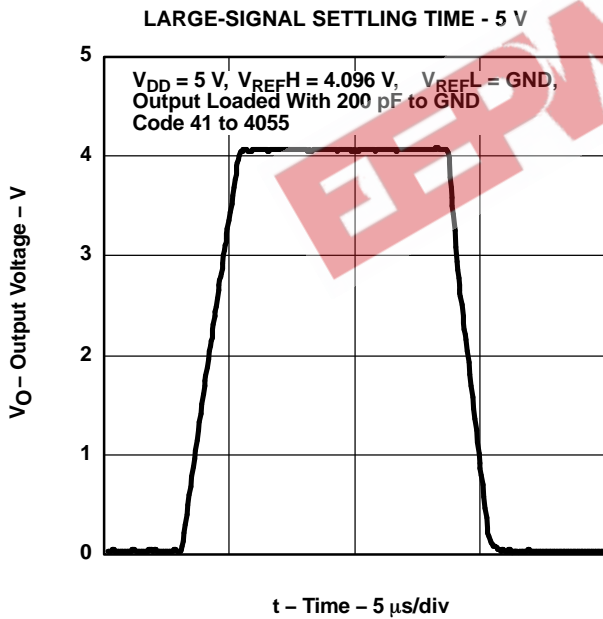
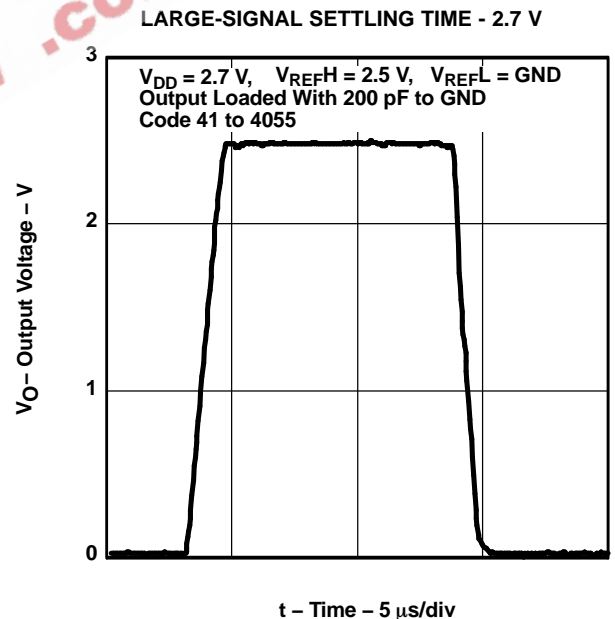


Figure 19.



t - Time - 5  $\mu\text{s}/\text{div}$

Figure 20.



t - Time - 5  $\mu\text{s}/\text{div}$

Figure 21.

TYPICAL CHARACTERISTICS (continued)

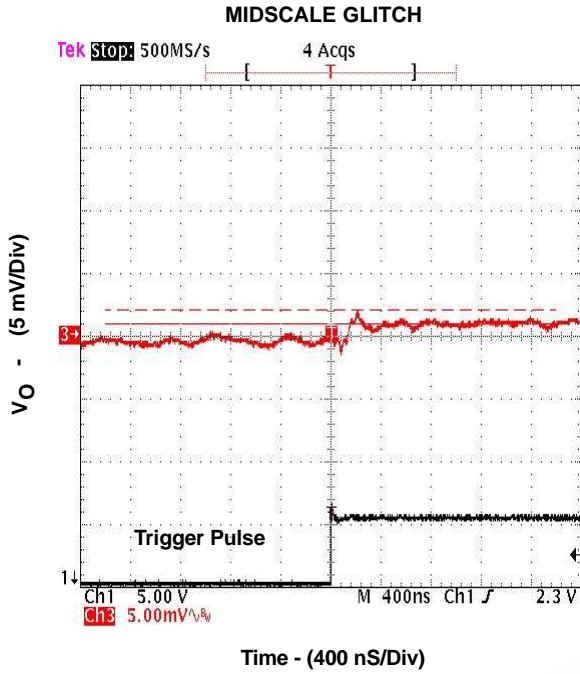


Figure 22.

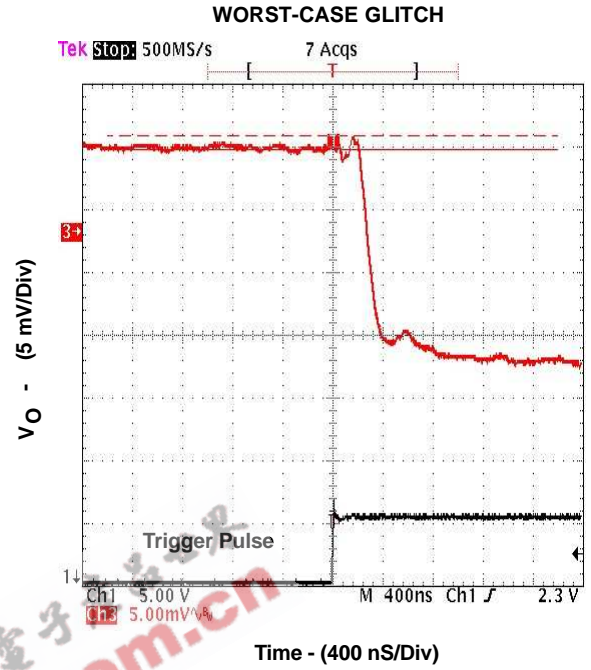


Figure 23.

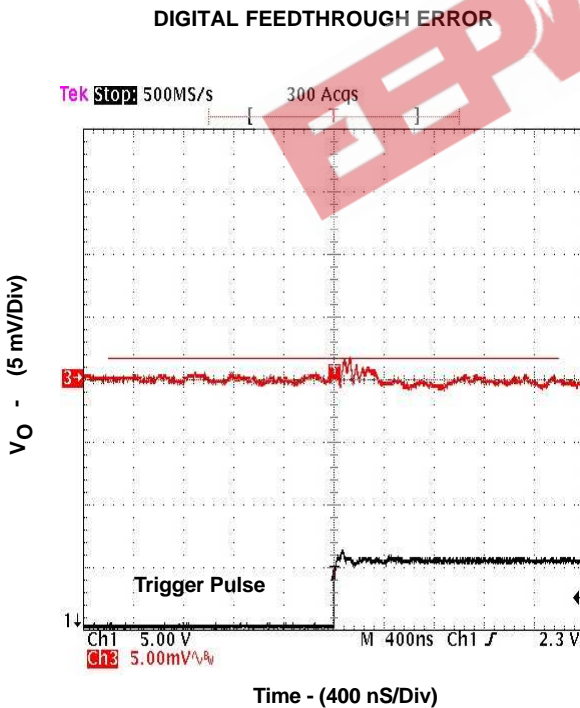


Figure 24.

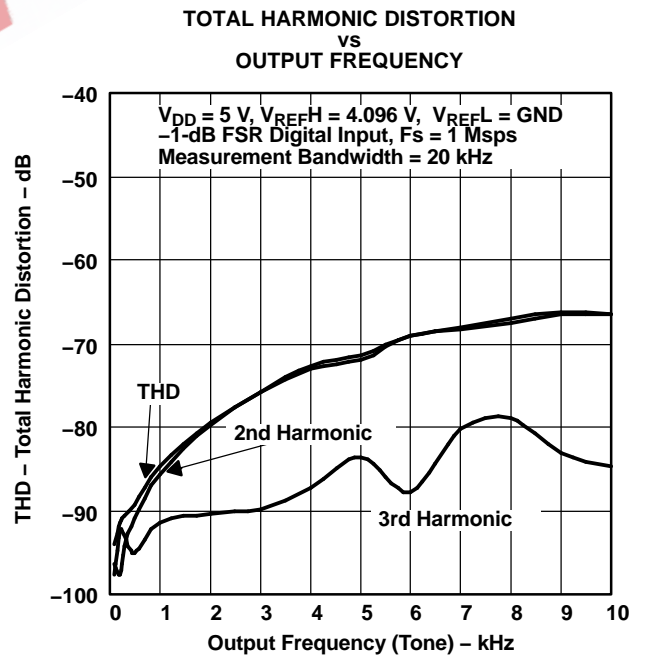


Figure 25.

**TYPICAL CHARACTERISTICS (continued)**

**3-Wire Serial Interface**

The DAC7551 digital interface is a standard 3-wire SPI/QSPI/Microwire/DSP-compatible interface.

**Table 1. Serial Interface Programming**

CONTROL				DATA BITS	FUNCTION
DB15	DB14	DB13 (PD1)	DB12 (PD0)	DB11–DB0	
X	X	0	0	data	Normal mode
X	X	0	1	X	Powerdown 1 k $\Omega$
X	X	1	0	X	Powerdown 100 k $\Omega$
X	X	1	1	X	Powerdown Hi-Z

EEPW 电子產品世界  
 .com.cn

**PRODUCT PREVIEW**

## THEORY OF OPERATION

### D/A SECTION

The architecture of the DAC7551 consists of a string DAC followed by an output buffer amplifier. Figure 26 shows a generalized block diagram of the DAC architecture.

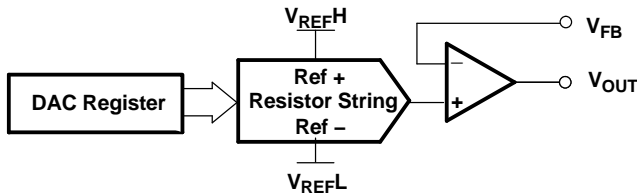


Figure 26. Typical DAC Architecture

The input coding to the DAC7551 is unsigned binary, which gives the ideal output voltage as:

$$V_{OUT} = 2 \times V_{REFL} + (V_{REFH} - V_{REFL}) \times D/4096$$

Where D = decimal equivalent of the binary code that is loaded to the DAC register which can range from 0 to 4095.

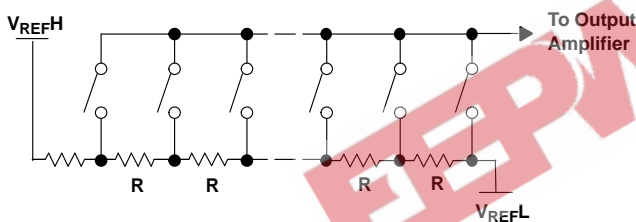


Figure 27. Typical Resistor String

### RESISTOR STRING

The resistor string section is shown in Figure 27. It is simply a string of resistors, each of value R. The digital code loaded to the DAC register determines at which node on the string the voltage is tapped off to be fed into the output amplifier. The voltage is tapped off by closing one of the switches connecting the string to the amplifier. Because it is a string of resistors, it is specified monotonic.

### OUTPUT BUFFER AMPLIFIERS

The output buffer amplifier is capable of generating rail-to-rail voltages on its output, which gives an output range of 0 V to  $V_{DD}$ . It is capable of driving a load of 2 k $\Omega$  in parallel with up to 1000 pF to GND. The source and sink capabilities of the output amplifier can be seen in the typical curves. The slew rate is 1 V/ $\mu$ s with a half-scale settling time of 3  $\mu$ s with the output unloaded.

### DAC External Reference Input

There is a single reference input pin for the DAC. The reference input is unbuffered. The user can have a reference voltage as low as 0.25 V and as high as  $V_{DD}$  because there is no restriction due to headroom and footroom of any reference amplifier.

It is recommended to use a buffered reference in the external circuit (e.g., REF3140). The input impedance is typically 100 k $\Omega$ .

### Power-On Reset

On power up, the internal register is cleared and the DAC channel is updated with zero-scale voltage. The DAC output remains in this state until valid data is written. This is particularly useful in applications where it is important to know the state of the DAC output while the device is powering up. In order not to turn on ESD protection devices,  $V_{DD}$  should be applied before any other pin is brought high.

### Power Down

The DAC7551 has a flexible power-down capability. During a power-down condition, the user has flexibility to select the output impedance of the DAC. During power-down operation, the DAC can have either 1-k $\Omega$ , 100-k $\Omega$ , or Hi-Z output impedance to ground.

### Asynchronous Clear

The DAC7551 output is asynchronously set to zero-scale voltage immediately after the  $\overline{CLR}$  pin is brought low. The  $\overline{CLR}$  signal resets all internal registers and therefore behaves like the Power-On Reset. The DAC7551 updates at the first rising edge of the  $\overline{SYNC}$  signal that occurs after the  $\overline{CLR}$  pin is brought back to high.

### SERIAL INTERFACE

The DAC7551 is controlled over a versatile 3-wire serial interface, which operates at clock rates up to 50 MHz and is compatible with SPI, QSPI, Microwire, and DSP interface standards.

In order to initialize the serial interface for the next update, the DAC7551 requires a falling SCLK edge after the rising  $\overline{SYNC}$ .

### 16-Bit Word and Input Shift Register

The input shift register is 16 bits wide. DAC data is loaded into the device as a 16-bit word under the control of a serial clock input, SCLK, as shown in the Figure 1 timing diagram. The 16-bit word, illustrated in Table 1, consists of four control bits followed by 12 bits of DAC data. The data format is straight binary

with all zeroes corresponding to 0-V output and all ones corresponding to full-scale output ( $V_{REF} - 1$  LSB). Data is loaded MSB first (Bit 15) where the first two bits (DB15 and DB14) are don't care bits. Bit 13 and bit 12 (DB13 and DB12) determine either normal mode operation or power-down mode (see Table 1).

The  $\overline{\text{SYNC}}$  input is a level-triggered input that acts as a frame synchronization signal and chip enable. Data can only be transferred into the device while  $\overline{\text{SYNC}}$  is low. To start the serial data transfer,  $\overline{\text{SYNC}}$  should be taken low, observing the minimum  $\overline{\text{SYNC}}$  to SCLK falling edge setup time,  $t_4$ . After  $\overline{\text{SYNC}}$  goes low, serial data is shifted into the device's input shift register on the falling edges of SCLK for 16 clock pulses.

The SPI interface is enabled after  $\overline{\text{SYNC}}$  becomes low and the data is continuously shifted into the shift register at each falling edge of SCLK. When  $\overline{\text{SYNC}}$  is brought high the last 16 bits stored in the shift register get latched into the DAC register, and the DAC updates.

### Daisy-Chain Operation

Serial Data Output (SDO) pin is provided to daisy-chain multiple DAC7551 devices in a system. As long as  $\overline{\text{SYNC}}$  is high the SDO pin is in a high-impedance state. When  $\overline{\text{SYNC}}$  is brought low the output of the internal shift register is tied to the SDO pin. As long as  $\overline{\text{SYNC}}$  is low, at each falling edge of SCLK, SDO duplicates SDIN signal with a 16-cycle delay. To support multiple devices in a daisy chain, SCLK and  $\overline{\text{SYNC}}$  signals are shared across all devices, and SDO of one DAC7551 should be tied to the SDIN of the next DAC7551. For  $n$  devices in such a daisy chain,  $16n$  SCLK cycles are required to shift the entire input data stream. After  $16n$  SCLK falling edges are received following a falling  $\overline{\text{SYNC}}$ , the data stream becomes complete, and  $\overline{\text{SYNC}}$  can be brought high to update  $n$  devices simultaneously. SDO operation is specified at a maximum SCLK speed of 10 MHz.

### INTEGRAL AND DIFFERENTIAL LINEARITY

The DAC7551 uses precision thin-film resistors providing exceptional linearity and monotonicity. Integral linearity error is typically within (+/-) 0.35 LSBs, and differential linearity error is typically within (+/-) 0.08 LSBs.

### GLITCH ENERGY

The DAC7551 uses a proprietary architecture that minimizes glitch energy. The code-to-code glitches are so low, they are usually buried within the wide-band noise and cannot be easily detected. The DAC7551 glitch is typically well under 0.1 nV-s. Such low glitch energy provides more than 10X improvement over industry alternatives.

### APPLICATION INFORMATION

#### Waveform Generation

Due to its exceptional linearity and low glitch, the DAC7551 is well suited for waveform generation (from DC to 10 kHz). The DAC7551 large-signal settling time is 5  $\mu$ s, supporting an update rate of 200 KSPS. However, the update rates can exceed 1 MSPS if the waveform to be generated consists of small voltage steps between consecutive DAC updates. To obtain a high dynamic range, REF3140 (4.096 V) or REF02 (5.0 V) are recommended for reference voltage generation.

#### Generating $\pm 5$ -V, $\pm 10$ -V, and $\pm 12$ -V Outputs For Precision Industrial Control

Industrial control applications can require multiple feedback loops consisting of sensors, ADCs, MCUs, DACs, and actuators. Loop accuracy and loop speed are the two important parameters of such control loops.

#### Loop Accuracy:

In a control loop, the ADC has to be accurate. Offset, gain, and the integral linearity errors of the DAC are not factors in determining the accuracy of the loop. As long as a voltage exists in the transfer curve of a monotonic DAC, the loop can find it and settle to it. On the other hand, DAC resolution and differential linearity do determine the loop accuracy, because each DAC step determines the minimum incremental change the loop can generate. A DNL error less than  $-1$  LSB (non-monotonicity) can create loop instability. A DNL error greater than  $+1$  LSB implies unnecessarily large voltage steps and missed voltage targets. With high DNL errors, the loop loses its stability, resolution, and accuracy. Offering 12-bit ensured monotonicity and  $\pm 0.08$  LSB typical DNL error, 755X DACs are great choices for precision control loops.

#### Loop Speed:

Many factors determine control loop speed. Typically, the ADC's conversion time, and the MCU's computation time are the two major factors that dominate the time constant of the loop. DAC settling time is rarely a dominant factor because ADC conversion times usually exceed DAC conversion times. DAC offset, gain, and linearity errors can slow the loop

down only during the start-up. Once the loop reaches its steady-state operation, these errors do not affect loop speed any further. Depending on the ringing characteristics of the loop's transfer function, DAC glitches can also slow the loop down. With its 1 MSPS (small-signal) maximum data update rate, DAC7551 can support high-speed control loops. Ultralow glitch energy of the DAC7551 significantly improves loop stability and loop settling time.

Generating Industrial Voltage Ranges:

For control loop applications, DAC gain and offset errors are not important parameters. This could be exploited to lower trim and calibration costs in a high-voltage control circuit design. Using a quad operational amplifier (OPA4130), and a voltage reference (REF3140), the DAC7551 can generate the wide voltage swings required by the control loop.

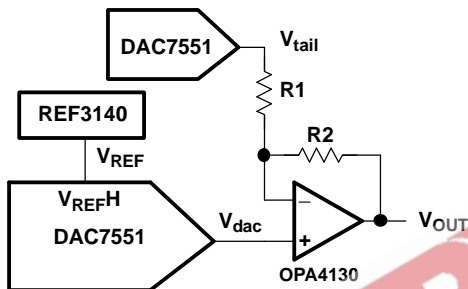


Figure 28. Low-cost, Wide-swing Voltage Generator for Control Loop Applications

The output voltage of the configuration is given by:

$$V_{out} = V_{REF} \left( \frac{R2}{R1} + 1 \right) \frac{Din}{4096} - V_{tail} \frac{R2}{R1} \quad (1)$$

Fixed R1 and R2 resistors can be used to coarsely set the gain required in the first term of the equation. Once R2 and R1 set the gain to include some minimal over-range, a single DAC7551 could be used to set the required offset voltages. Residual errors are not an issue for loop accuracy because offset and gain errors could be tolerated. One DAC7551 can provide the  $V_{tail}$  voltages, while four additional DAC7551 devices can provide  $V_{dac}$  voltages to generate four high-voltage outputs. A single SPI interface is sufficient to control all five DAC7551 devices in a daisy-chain configuration.

For  $\pm 5$ -V operation: R1 = 10 k $\Omega$ , R2 = 15 k $\Omega$ ,  $V_{tail}$  = 3.33 V,  $V_{REF}$  = 4.096 V

For  $\pm 10$ -V operation: R1 = 10 k $\Omega$ , R2 = 39 k $\Omega$ ,  $V_{tail}$  = 2.56 V,  $V_{REF}$  = 4.096 V

For  $\pm 12$ -V operation: R1 = 10 k $\Omega$ , R2 = 49 k $\Omega$ ,  $V_{tail}$  = 2.45 V,  $V_{REF}$  = 4.096 V



**PACKAGING INFORMATION**

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
DAC7551IDRNR	PREVIEW	SON	DRN	12	250	TBD	Call TI	Call TI
DAC7551IDRNT	PREVIEW	SON	DRN	12	250	TBD	Call TI	Call TI

<sup>(1)</sup> The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS) or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Green (RoHS & no Sb/Br):** TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

**Important Information and Disclaimer:** The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

## IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, modifications, enhancements, improvements, and other changes to its products and services at any time and to discontinue any product or service without notice. Customers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All products are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its hardware products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by government requirements, testing of all parameters of each product is not necessarily performed.

TI assumes no liability for applications assistance or customer product design. Customers are responsible for their products and applications using TI components. To minimize the risks associated with customer products and applications, customers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any TI patent right, copyright, mask work right, or other TI intellectual property right relating to any combination, machine, or process in which TI products or services are used. Information published by TI regarding third-party products or services does not constitute a license from TI to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. Reproduction of this information with alteration is an unfair and deceptive business practice. TI is not responsible or liable for such altered documentation.

Resale of TI products or services with statements different from or beyond the parameters stated by TI for that product or service voids all express and any implied warranties for the associated TI product or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

Following are URLs where you can obtain information on other Texas Instruments products and application solutions:

<b>Products</b>		<b>Applications</b>	
Amplifiers	<a href="http://amplifier.ti.com">amplifier.ti.com</a>	Audio	<a href="http://www.ti.com/audio">www.ti.com/audio</a>
Data Converters	<a href="http://dataconverter.ti.com">dataconverter.ti.com</a>	Automotive	<a href="http://www.ti.com/automotive">www.ti.com/automotive</a>
DSP	<a href="http://dsp.ti.com">dsp.ti.com</a>	Broadband	<a href="http://www.ti.com/broadband">www.ti.com/broadband</a>
Interface	<a href="http://interface.ti.com">interface.ti.com</a>	Digital Control	<a href="http://www.ti.com/digitalcontrol">www.ti.com/digitalcontrol</a>
Logic	<a href="http://logic.ti.com">logic.ti.com</a>	Military	<a href="http://www.ti.com/military">www.ti.com/military</a>
Power Mgmt	<a href="http://power.ti.com">power.ti.com</a>	Optical Networking	<a href="http://www.ti.com/opticalnetwork">www.ti.com/opticalnetwork</a>
Microcontrollers	<a href="http://microcontroller.ti.com">microcontroller.ti.com</a>	Security	<a href="http://www.ti.com/security">www.ti.com/security</a>
		Telephony	<a href="http://www.ti.com/telephony">www.ti.com/telephony</a>
		Video & Imaging	<a href="http://www.ti.com/video">www.ti.com/video</a>
		Wireless	<a href="http://www.ti.com/wireless">www.ti.com/wireless</a>

Mailing Address: Texas Instruments  
Post Office Box 655303 Dallas, Texas 75265